TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

## TC74VHC373F,TC74VHC373FT,TC74VHC373FK

#### Octal D-Type Latch with 3-State Output

The TC74VHC373 is an advanced high speed CMOS OCTAL LATCH with 3-STATE OUTPUT fabricated with silicon gate C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

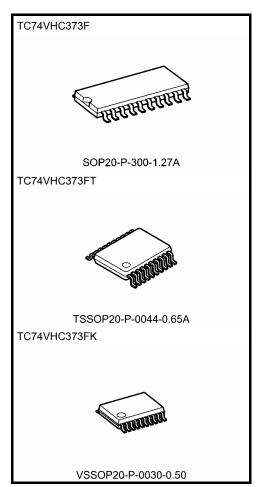
This 8-bit D-type latch is controlled by a latch enable input (LE) and an output enable input ( $\overline{OE}$ ).

When the  $\overline{\mbox{OE}}$  input is high, the eight outputs are in a high impedance state.

An input protection circuit ensures that 0 to 5.5~V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5~V to 3~V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

#### **Features**

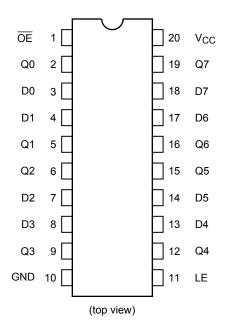
- High speed:  $t_{pd} = 5.0 \text{ ns (typ.)}$  at  $V_{CC} = 5 \text{ V}$
- Low power dissipation:  $I_{CC} = 4 \mu A \text{ (max)}$  at  $T_{a} = 25 \text{°C}$
- High noise immunity:  $V_{NIH} = V_{NIL} = 28\% V_{CC}$  (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays:  $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range:  $V_{CC \text{ (opr)}} = 2 \text{ to } 5.5 \text{ V}$
- Low noise: VOLP = 0.9 V (max)
- Pin and function compatible with 74ALS373



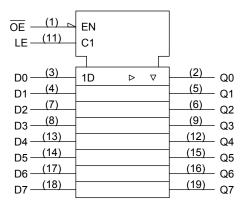
Weight

SOP20-P-300-1.27A : 0.22 g (typ.) TSSOP20-P-0044-0.65A : 0.08 g (typ.) VSSOP20-P-0030-0.50 : 0.03 g (typ.)

#### **Pin Assignment**



#### **IEC Logic Symbol**



#### **Truth Table**

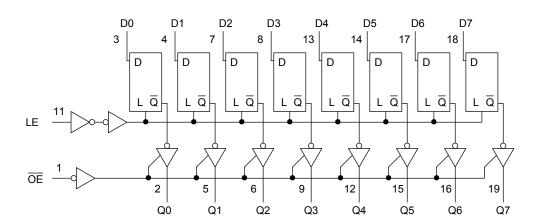
	Inputs	Output	
ŌE	LE	D	Output
Н	Х	Х	Z
L	L	Х	Qn
L	Н	L	L
L	Н	Н	Н

X: Don't care

Z: High impedance

Q<sub>n</sub>: Q outputs are latched at the time when the LE input is taken to a low logic level.

#### **System Diagram**





#### **Absolute Maximum Ratings (Note)**

Characteristics	Symbol	Rating	Unit
Supply voltage range	V <sub>CC</sub>	−0.5 to 7.0	V
DC input voltage	V <sub>IN</sub>	−0.5 to 7.0	V
DC output voltage	Vout	-0.5 to V <sub>CC</sub> + 0.5	V
Input diode current	l <sub>IK</sub>	-20	mA
Output diode current	lok	±20	mA
DC output current	I <sub>OUT</sub>	±25	mA
DC V <sub>CC</sub> /ground current	I <sub>CC</sub>	±75	mA
Power dissipation	PD	180	mW
Storage temperature	T <sub>stg</sub>	−65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

### **Operating Ranges (Note)**

Characteristics	Symbol	Rating	Unit	
Supply voltage	V <sub>CC</sub>	2.0 to 5.5	V	
Input voltage	V <sub>IN</sub>	0 to 5.5	V	
Output voltage	V <sub>OUT</sub>	0 to V <sub>CC</sub>	٧	
Operating temperature	T <sub>opr</sub>	−40 to 85	ç	
Input rise and fall time	dt/dv	0 to 100 (V <sub>CC</sub> = 3.3 ± 0.3 V)	ns/V	
input rise and rail time	avav	0 to 20 (V <sub>CC</sub> = 5 ± 0.5 V)	IIS/V	

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either  $V_{\text{CC}}$  or GND.

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## **Electrical Characteristics**

#### **DC Characteristics**

Characteristics	Symbol	Test Condition			Ta = 25°C		Ta = −40 to 85°C		Unit	
		١		V <sub>CC</sub> (V)	Min	Тур.	Max	Min	Max	
High-level input voltage	V <sub>IH</sub>	_		2.0 3.0 to 5.5	1.50 V <sub>CC</sub> × 0.7		_	1.50 V <sub>CC</sub> × 0.7	_	٧
Low-level input voltage	V <sub>IL</sub>	-		2.0 3.0 to 0.5			0.50 V <sub>CC</sub> × 0.3	-	0.50 V <sub>CC</sub> × 0.3	V
High-level output voltage	V <sub>ОН</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA I <sub>OH</sub> = -4 mA	2.0 3.0 4.5 3.0	1.9 2.9 4.4 2.58	2.0 3.0 4.5	_ _ _ _	1.9 2.9 4.4 2.48	_ _ _ _	V
			I <sub>OH</sub> = −8 mA	4.5	3.94	_	-	3.80	-	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 μA	2.0 3.0 4.5 3.0	_ _ _ _	0.0 0.0 0.0	0.1 0.1 0.1 0.36	_ 	0.1 0.1 0.1 0.44	٧
			I <sub>OL</sub> = 8 mA	4.5	_	_	0.36	_	0.44	
3-state output off-state current	I <sub>OZ</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = V_{CC}$ or GND		5.5	_	_	±0.25	_	±2.50	μΑ
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0 to 5.5	_	_	±0.1	_	±1.0	μΑ
Quiescent supply current	Icc	V <sub>IN</sub> = V <sub>CC</sub> or	GND	5.5	_	_	4.0	_	40.0	μА

## Timing Requirements (input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition	Test Condition		Ta = 25°C		Unit	
			V <sub>CC</sub> (V)	Тур.	Limit	Limit		
Minimum pulse width	t <sub>w (H)</sub>		$3.3 \pm 0.3$	_	5.0	5.0	20	
(LE)		_	5.0 ± 0.5	_	5.0	5.0	ns	
Minimum act un timo	+	_	$3.3 \pm 0.3$	_	4.0	4.0	20	
Minimum set-up time	ts		$5.0 \pm 0.5$	_	4.0	4.0	ns	
Minimum hold time	t <sub>h</sub>	-	$3.3 \pm 0.3$	_	1.0	1.0	20	
			5.0 ± 0.5	_	1.0	1.0	ns	



#### AC Electrical Characteristics (input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics Symbol	Symbol	Tes	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit
	,		V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Тур.	Max	Min	Max	
			3.3 ± 0.3	15	_	7.0	11.0	1.0	13.0	ns
Propagation delay time	$t_{pLH}$	_	3.5 ± 0.5	50	I	9.5	14.5	1.0	16.5	
(LE-Q)	$t_{pHL}$		5.0 ± 0.5	15	I	4.9	7.2	1.0	8.5	113
			3.0 1 0.5	50	I	6.4	9.2	1.0	10.5	
			$3.3 \pm 0.3$	15	1	7.3	11.4	1.0	13.5	
Propagation delay time	$t_{pLH}$	_	3.5 1 0.5	50	I	9.8	14.9	1.0	17.0	ns
(D-Q)	$t_{pHL}$		5.0 ± 0.5	15	1	5.0	7.2	1.0	8.5	113
				50	1	6.5	9.2	1.0	10.5	
	<sup>t</sup> pZL <sup>t</sup> pZH	R <sub>L</sub> = 1 kΩ	$3.3 \pm 0.3$ $5.0 \pm 0.5$	15	1	7.3	11.4	1.0	13.5	ns
3-state output enable				50	1	9.8	14.9	1.0	17.0	
time				15	1	5.5	8.1	1.0	9.5	
				50	I	7.0	10.1	1.0	11.5	
3-state output disable	$t_{pLZ}$	R <sub>L</sub> = 1 kΩ	$3.3 \pm 0.3$	50	1	9.5	13.2	1.0	15.0	ns
time	$t_{pHZ}$		$5.0 \pm 0.5$	50	1	6.5	9.2	1.0	10.5	115
Output to output akow	t <sub>osLH</sub>	(Note 1)	$3.3 \pm 0.3$	50	_	_	1.5	_	1.5	ns
Output to output skew	$t_{osHL}$	(Note 1)	5.0 ± 0.5	50	_	_	1.0	_	1.0	
Input capacitance	C <sub>IN</sub>		_		_	4	10	_	10	pF
Output capacitance	C <sub>OUT</sub>				_	6	_	_	_	pF
Power dissipation capacitance	C <sub>PD</sub>			(Note 2)	_	27	_	_	_	pF

Note 1: Parameter guaranteed by design.

 $t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|$ 

Note 2: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

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Average operating current can be obtained by the equation:

And the total CPD when n pcs. of Latch operate can be gained by the following equation:

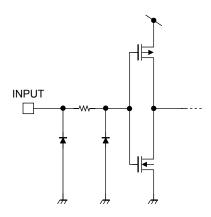
C<sub>PD</sub> (total) = 14 + 13·n



## Noise Characteristics (input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition		Ta =	Unit	
Characteristics	Symbol		V <sub>CC</sub> (V)	Тур.	Max	Offic
Quiet output maximum dynamic V <sub>OL</sub>	$V_{OLP}$	C <sub>L</sub> = 50 pF	5.0	0.5	0.8	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	C <sub>L</sub> = 50 pF	5.0	-0.5	-0.8	V
Minimum high level dynamic input voltage	$V_{IHD}$	C <sub>L</sub> = 50 pF	5.0	_	3.5	V
Maximum low level dynamic input voltage	$V_{ILD}$	C <sub>L</sub> = 50 pF	5.0	_	1.5	V

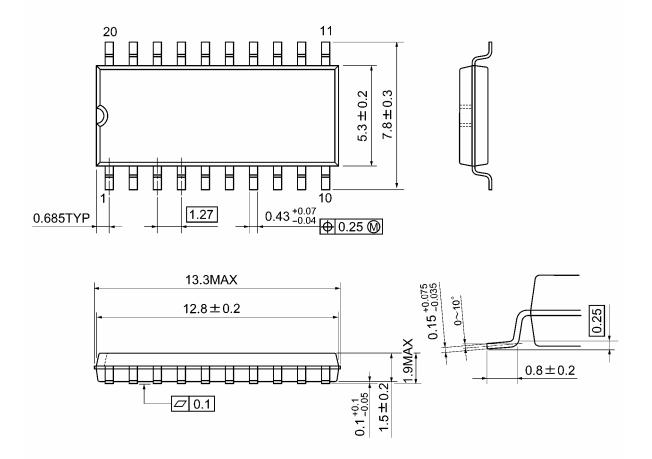
# Input Equivalent Circuit



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## **Package Dimensions**

SOP20-P-300-1.27A Unit: mm



Weight: 0.22 g (typ.)

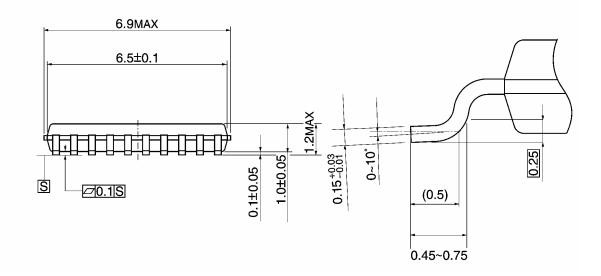
## **Package Dimensions**

TSSOP20-P-0044-0.65A

Unit: mm

 $0.22\substack{+0.09 \\ -0.06}$ 

0.65



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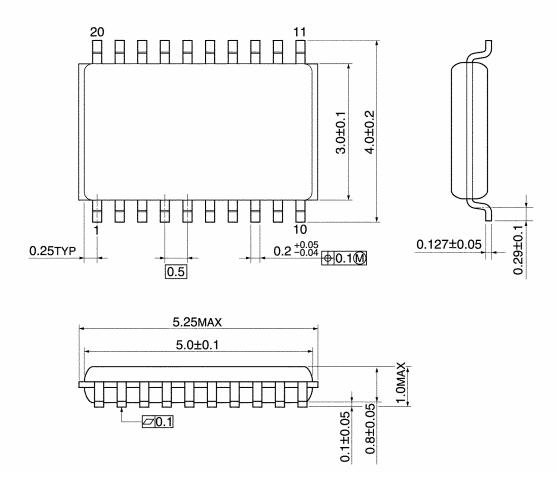
<del>| |</del>0.13M

Weight: 0.08 g (typ.)

0.325TYP

## **Package Dimensions**

VSSOP20-P-0030-0.50 Unit: mm



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Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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